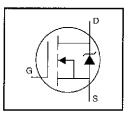


IRLIZ44G

HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation= 2.5KVRMS ®
- Sink to Lead Creepage Dist.= 4.8mm
- Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS}=4V & 5V
- Fast Switching
- Ease of Paralleling

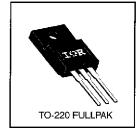


$V_{DSS} = 60V$ $R_{DS(on)} = 0.028\Omega$ $I_{\rm D} = 30A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



Absolute Maximum Ratings

	Parameter	Max.	Units
lp @ Tc = 25°C	Continuous Drain Current, VGS @ 5.0 V	30	
In @ Tc = 100°C	Continuous Drain Current, V _{GS} @ 5.0 V	21	Α
I _{DM}	Pulsed Drain Current ①	120	
P _D @ T _C = 25°C	Power Dissipation	48	W
	Linear Derating Factor	0.32	W/°C
V _{GS}	Gate-to-Source Voltage	±10	V
EAS	Single Pulse Avalanche Energy @	400	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.5	V/ns
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Reuc	Junction-to-Case		_	3.1	°C/W
ReJA	Junction-to-Ambient	_	_	65	C/VV

Document Number: 90406 www.vishav.com 1415



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
V(BR)DSS	Drain-to-Source Breakdown Voltage	60	_	_	V	V _{GS} =0V, I _D = 250μA
ΔV _{(BH)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	_	0.070	_	V/°C	Reference to 25°C, I _D = 1mA
D	Static Drain-to-Source On-Resistance		_	0.028	Ω	V _{GS} =5.0V, I _D =18A €
R _{DS(on)}	Static Diam-to-Source Off-Hesistance	_	_	0.039	32	V _{GS} =4.0V, I _D =15A ④
V _{GS(th)}	Gate Threshold Voltage	1.0	_	2.0	٧	V _{DS} =V _{GS} , I _D = 250μA
g/s	Forward Transconductance	22		_	S	V _{DS} =25V, I _D =18A ④
L	Drain-to-Source Leakage Current		_	25	uА	V _{DS} =60V, V _{GS} =0V
loss	Diani-to-Source Leakage Current	_	_	250	μΛ	V _{DS} =48V, V _{GS} =0V, T _J =150°C
1	Gate-to-Source Forward Leakage	_	_	100	nA	V _{GS} =10V
less	Gate-to-Source Reverse Leakage		_	-100	, IIA	V _{GS} =-10V
Q_g	Total Gate Charge		_	66		I _D =51A
Q _{gs}	Gate-to-Source Charge	_	_	12	nC	V _{DS} =48V
Q_{gd}	Gate-to-Drain ("Miller") Charge	_	-	43		V _{CS} =5.0V See Fig. 6 and 13 €
t _{d(on)}	Turn-On Delay Time	_	17	_		V _{DD} =30V
tr	Rise Time	<u> </u>	230	_	ns	I _D =51A
t _{d(off)}	Turn-Off Delay Time	_	42			R _G =4.6Ω
tı	Fall Time	_	110	_		R _D =0.56Ω See Figure 10 @
L _D	Internal Drain Inductance	_	4.5	. —	nH	Between lead, 6 mm (0.25in.) from package
Ls	Internal Source Inductance		7.5	-	,,,,	and center of die contact
Ciss	Input Capacitance	_	3300	_		V _{GS} =0V
Coss	Output Capacitance	_	1200	_	рF	V _{DS} = 25V
Cras	Reverse Transfer Capacitance		200	_		f=1.0MHz See Figure 5
С	Drain to Sink Capacitance		12	_	рF	f=1,0MHz

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)	: —	_	30	А	MOSFET symbol showing the
Ism	Pulsed Source Current (Body Diode) ①	_		120		integral reverse p-n junction diode.
V _{SD}	Diode Forward Voltage	. —		2.5	٧	TJ=25°C, 1S=30A, VGS=0V (4)
t _{rr}	Reverse Recovery Time		90	180	ns	TJ=25°C, IF=51A
Qrr	Reverse Recovery Charge	-	0.65	1.3	μC	di/dt=100A/μs ⊛
ton	Forward Tum-On Time	Intrinsi	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Lb)			

Notes:

- ① Repetitive rating; pulse width limited by max, junction temperature (See Figure 11)
- ③ I_{SD}≤51A, di/dt≤250A/μs, V_{DD}≤V(BR)DSS, TJ≤175°C
- ⑤ t=60s, f=60Hz

- V_{DD}=25V, starting T_J=25°C, L=518μH
 R_G=25Ω, I_{AS}=30A (See Figure 12)
- ④ Pulse width ≤ 300 us; duty cycle ≤2%.



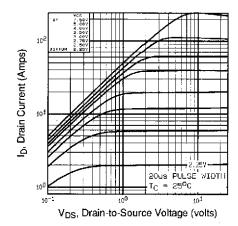


Fig 1. Typical Output Characteristics, Tc=25°C

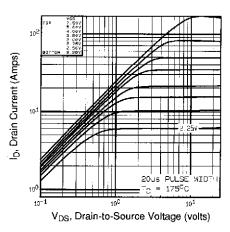


Fig 2. Typical Output Characteristics, T_C=175°C

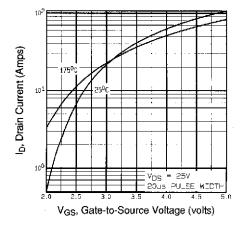


Fig 3. Typical Transfer Characteristics

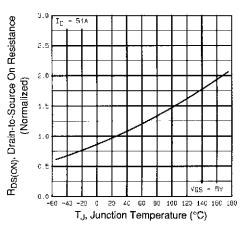


Fig 4. Normalized On-Resistance Vs. Temperature

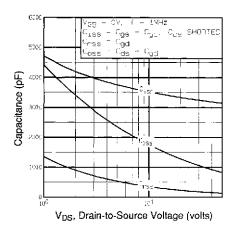


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

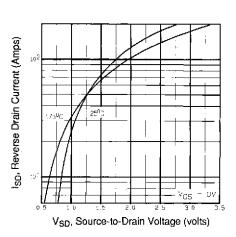


Fig 7. Typical Source-Drain Diode Forward Voltage

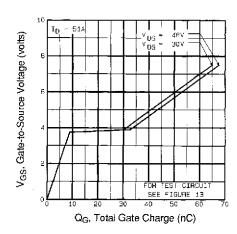


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

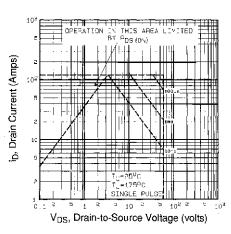


Fig 8. Maximum Safe Operating Area

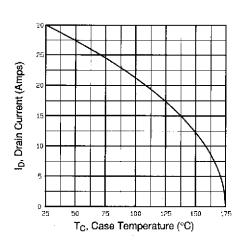


Fig 9. Maximum Drain Current Vs. Case Temperature

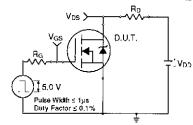


Fig 10a. Switching Time Test Circuit

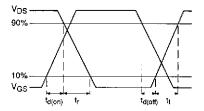


Fig 10b. Switching Time Waveforms

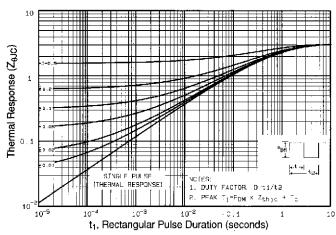


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

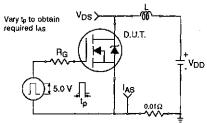


Fig 12a. Unclamped Inductive Test Circuit

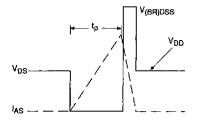


Fig 12b. Unclamped Inductive Waveforms

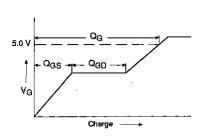


Fig 13a. Basic Gate Charge Waveform

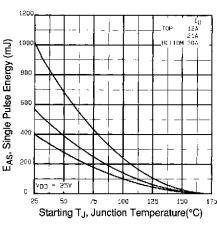


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

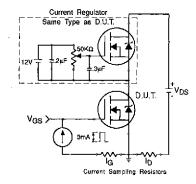


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit - See page 1505

Appendix B: Package Outline Mechanical Drawing - See page 1510

Appendix C: Part Marking Information - See page 1517

International Rectifier



Vishay

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